

## SMP1255PUTG



# SMP1255PUTG TVS Arrays

#### Description

The SMP1255P integrates 3 channels of ultra-low capacitance steering diodes and a low voltage TVS diode to provide maximum protection of the USB data and ID pins against ESD per the IEC61000-4-2 standard. An additional 12V TVS diode is included to provide lightning surge protection for the USB VBUS pin up to 100A (tP=8/20µs) per the IEC61000-4-5 standard. The SMP1255P provides superior protection for current intensive applications such as fast charging peripharals.

The SMP1255P comes in a space saving 2.0x1.8mm µDFN package with a typical height of 0.55mm making it an ideal solution for smart phones, tablets, and other portable electronics.

#### Features

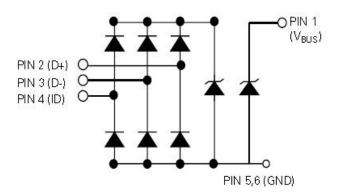
For USB Voltage Bus Pin (V<sub>BUS</sub>)

- IEC 61000-4-2 (ESD) ±30kV (air), ±30kV (contact)
- IEC 61000-4-5 (lightning) 100A (8/20 µ s)
- IEC 61000-4-4 (EFT) 80A (5/50ns)
- Protection for VBUS operating up to 12V
- Benchmark setting protection
- High current handling capability for fast charging
- applications

For USB Data Pin (D+, D-, ID)

- IEC 61000-4-2 (ESD) ±15kV (air), ±12kV (contact)
- IEC 61000-4-5 (lightning) 4A (8/20 μ s)
- IEC 61000-4-4 (EFT) 40A (5/50ns)
- 0.5pF capacitance
- Low clamping voltage and dynamic resistance (0.3 Ω)

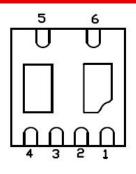
#### **Functional Block Diagram**



#### Applications

- USB 2.0
- USB OTG
- µUSB
- Protection for the VBUS circuit on USB2.0
- Fast Charging

#### Pinout





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### **Ordering Information**

Device	Deekage	Packaging	D0/D4	Packaging	Min. Order
Device	Package	Options	P0/P1	Speciications	Qty.
SMP1255PUTG	µDFN-6	Tape & Reel - 8mm tape/7" reel	2mm/4mm	EIA RS-481	3000

For information on tape and reel specifications, including part orientation and tape sizes, please refer to our tape and reel packaging specification.

#### Absolute Maximum Ratings @T<sub>A</sub>=25°C unless otherwise specified

Parameter	Symbol	Value	Units
Peak Current (tp=8/20µs)	I <sub>PP</sub> (Pin1)	100	А
Peak Current (tp=8/20µs)	I <sub>PP</sub> (Pin2-4)	4	А
Operating Temperature	Тор	-40 to + 125	°C
Storage Temperature	TSTOR	-55 to + 150	°C

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

### **Electrical Characteristics (TOP=25°C)**

Characteristics	Symbol	Condition	Min.	Тур.	Max.	Units	
USB V <sub>BUS</sub> (Pin 1)	•						
Reverse Stand-Off Voltage	V <sub>RWM</sub>	Pin 1 to GND	-	-	12	V	
Reverse Breakdown Voltage	VBR	I⊤=1mA, Pin 1 to GND	13	13.5	16.5	V	
Reverse Leakage Current	I <sub>LEAK</sub>	V <sub>R</sub> =12V, Pin 1 to GND	-	-	0.1	μA	
Forward Voltage	VF	I <sub>F</sub> =10mA, GND to Pin 1	0.6	0.7	1.0	V	
Clamping Voltage <sup>1</sup>	Vc	I <sub>PP</sub> = 30A, tp=8/20µs, Fwd	-	16.5	18	V	
Clamping Voltage	VC	I <sub>PP</sub> = 100A, tp=8/20µs, Fwd	-	19.5	25	V	
ESD With stand Voltage <sup>1</sup>		IEC61000-4-2 (Contact)	±30	-	-	kV	
	VESD	IEC61000-4-2 (Air)	±30	-	-	kV	
Diode Capacitance <sup>1</sup>	CD	Reverse Bias=0V, f=1 MHz	-	1300	2500	pF	
USB D+, D-, ID (Pin 2, 3, 4)	•						
Reverse Stand-Off Voltage	VRWM	Pin 2, 3 and 4 to GND	-	-	4	V	
Reverse Breakdown Voltage	VBR	I⊤=2µA, Pin 2, 3 and 4 to GND	4.5	6.0	7.5	V	
Reverse Leakage Current		$V_R$ =2V, Pin 2, 3 and 4 to GND	-	-	0.02		
	ILEAK	V <sub>R</sub> =4V, Pin 2, 3 and 4 to GND	-	-	0.1	μA	
Clamping Voltage <sup>1</sup>		I <sub>PP</sub> = 1A, tp=8/20µs, Fwd	-	6.6	8.0	V	
	Vc	I <sub>PP</sub> = 2A, tp=8/20µs, Fwd	-	7.0	8.5	V	
Dynamic Resistance	Rdyn	TLP, tp=100ns, Pin 2, 3 and 4 to GND <sup>2</sup>	-	0.3	-	Ω	
ESD With stand Voltage <sup>1</sup>		IEC61000-4-2 (Contact)	±12	-	-	kV	
	VESD	IEC61000-4-2 (Air)	±15	-	-	kV	
Diode Capacitance <sup>1</sup>	CI/O-GND	Reverse Bias=0V, f=1 MHz	-	0.5	0.6	pF	

Note: 1. Parameter is guaranteed by design and/or device characterization.

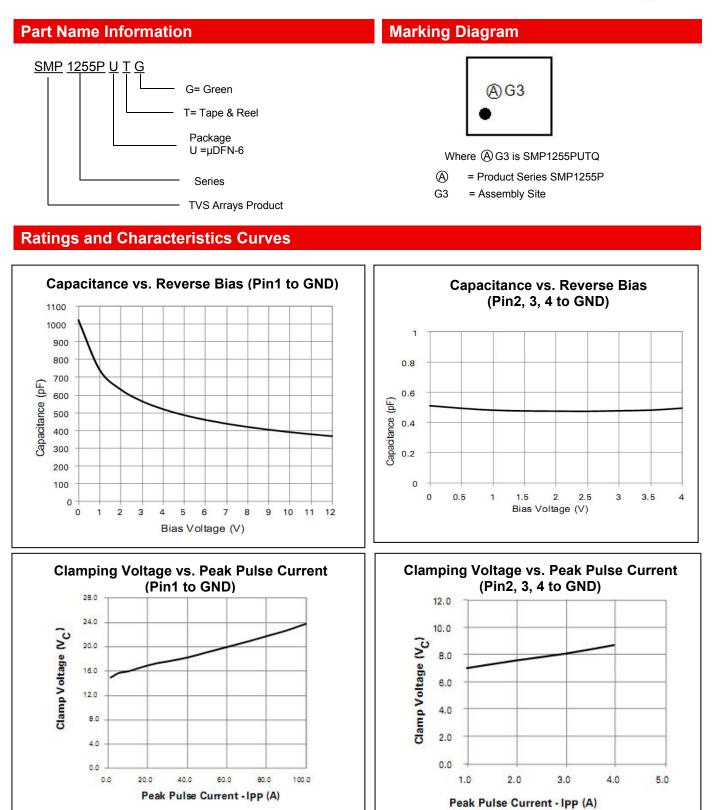
2. Transmission Line Pulse (TLP) Test Setting:  $t_P$ =100ns,  $t_r$ =0.2ns  $I_{TLP}$  and  $V_{TLP}$  averaging window: star  $t_1$ =70ns to  $t_2$ =90ns

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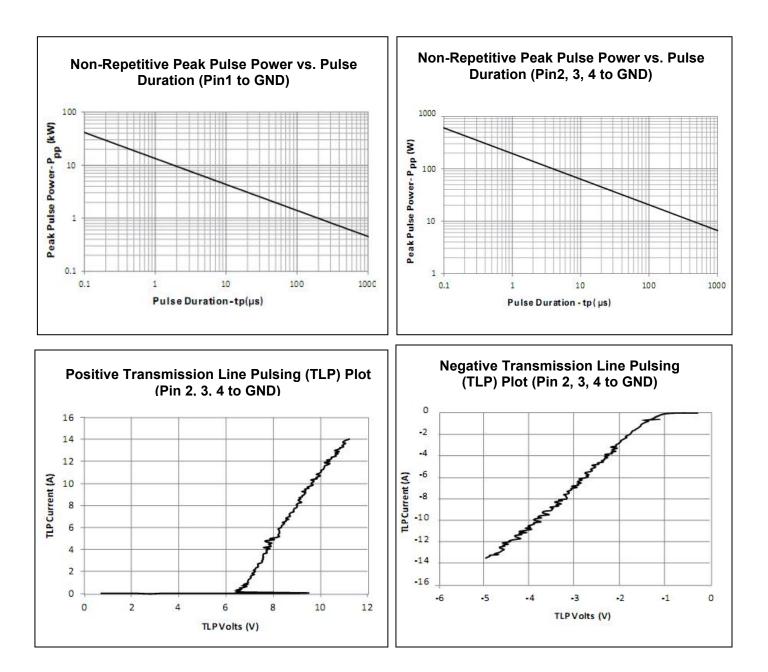
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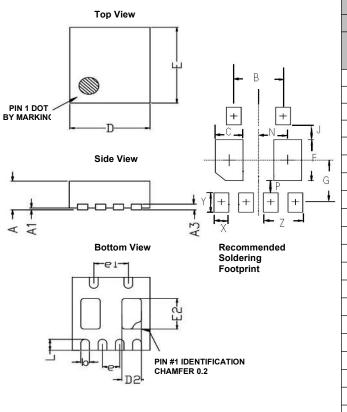








### Mechanical Dimensions µDFN-6

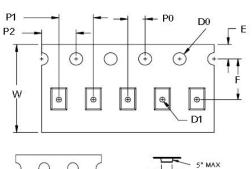


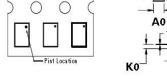
µDFN-6(1.8×2.0×0.55mm)						
JEDEC MO-229						
Symbol	Millimeters			Inches		
Symbol	Min	Тур	Max	Min	Тур	Max
Α	0.50	0.55	0.60	0.020	0.022	0.024
A1	0.00	-	0.05	0.000	-	0.002
A3	C	).15Ref		0.006Ref		
D	1.75	1.80	1.85	0.069	0.071	0.073
Е	1.95	2.00	2.05	0.077	0.079	0.081
b	0.15	0.20	0.25	0.006	0.008	0.010
L	0.20	0.30	0.40	0.008	0.012	0.016
D2	0.35	0.45	0.55	0.014	0.018	0.022
E2	0.74	0.84	0.94	0.029	0.033	0.037
е	0.40 BSC			0.016 BSC		
e1	0.80 BSC		0.031 BSC			
В	0.	0.80 BSC		0.031 BSC		
С	0.35	0.45	0.55	0.014	0.018	0.022
F	0.81	0.84	0.87	0.032	0.033	0.034
G	0.82	0.85	0.88	0.032	0.033	0.034
J	0.24	0.25	0.26	0.010	0.010	0.010
Ν	0.47	0.48	0.49	0.018	0.019	0.020
Р	0.24	0.25	0.26	0.010	0.010	0.010
Х	0.23	0.24	0.25	0.009	0.009	0.009
Y	0.35	0.36	0.37	0.014	0.014	0.014
Z	0.62	0.64	0.66	0.024	0.025	0.026

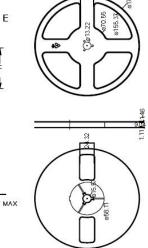
### Embossed Carrier Tape & Reel Specification —µDFN-6

5°

R0







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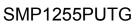
Symbol	Millimeters
A0	1.95+/-0.05
B0	2.30+/-0.05
D0	1.50+0.10
D1	Φ 0.60+0.05
Е	1.75+/-0.10
F	3.50+/-0.05
K0	0.75+/-0.05
P0	2.00+/-0.05
P1	4.00+/-0.10
P2	4.00+/-0.10
Т	0.25+/-0.02
w	8.00+0.30/-0.10

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### Data Sheet N1749, REV. A





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